

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination LAVELLE ET AL.	
		10/086,174	Examiner	Art Unit Ulka J. Chauhan
			2676	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,697,918	02-2004	Rowlands, Joseph B.	711/133
	B	US-6,535,218	03-2003	Schlapp, Elizabeth J.	345/545
	C	US-6,437,789	08-2002	Tidwell et al.	345/557
	D	US-6,415,358	07-2002	Arimilli et al.	711/134
	E	US-6,119,205	09-2000	Wicki et al.	711/143
	F	US-6,000,017	12-1999	Hayek et al.	711/144
	G	US-5,918,245	06-1999	Yung, Robert	711/122
	H	US-5,767,865	06-1998	Inoue et al.	345/519
	I	US-5,579,473	11-1996	Schlapp et al.	345/557
	J	US-5,544,306	08-1996	Deering et al.	345/545
	K	US-5,787,473	07-1998	Vishlitzky et al.	711/134
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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